

## OptiMOS™ -5 Power Transistor


**RoHS**

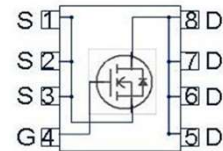
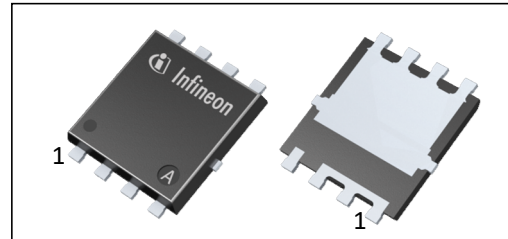
### Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel - Enhancement mode - Logic Level
- MSL1 up to 260°C peak reflow
- 175 °C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

### Product Summary

|                  |    |    |
|------------------|----|----|
| $V_{DS}$         | 80 | V  |
| $R_{DS(on),max}$ | 14 | mΩ |
| $I_D$            | 40 | A  |

### PG-TDSON-8-33



| Type            | Package                       | Marking  |
|-----------------|-------------------------------|----------|
| IAUC40N08S5L140 | <a href="#">PG-TDSON-8-33</a> | 5N08L140 |

**Maximum ratings**, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                                    | Symbol         | Conditions                                                      | Value        | Unit |
|----------------------------------------------|----------------|-----------------------------------------------------------------|--------------|------|
| Drain current                                | $I_D$          | $T_C=25\text{ °C}$ , $V_{GS}=10\text{ V}$ , DC <sup>1,2)</sup>  | 40           | A    |
|                                              |                | $T_C=100\text{ °C}$ , $V_{GS}=10\text{ V}$ , DC <sup>1,2)</sup> | 28           |      |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$  | $T_C=25\text{ °C}$                                              | 160          |      |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$       | $I_D=18\text{ A}$                                               | 32           | mJ   |
| Avalanche current, single pulse              | $I_{AS}$       | -                                                               | 18           | A    |
| Gate source voltage                          | $V_{GS}$       | -                                                               | ±20          | V    |
| Power dissipation                            | $P_{tot}$      | $T_C=25\text{ °C}$                                              | 56           | W    |
| Operating and storage temperature            | $T_j, T_{stg}$ | -                                                               | -55 ... +175 | °C   |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics<sup>2)</sup>**

|                                                      |            |   |   |      |     |     |
|------------------------------------------------------|------------|---|---|------|-----|-----|
| Thermal resistance, junction - case                  | $R_{thJC}$ | - | - | -    | 2.7 | K/W |
| Thermal resistance, junction - ambient <sup>4)</sup> | $R_{thJA}$ | - | - | 28.5 | -   |     |

**Electrical characteristics, at  $T_j=25^\circ\text{C}$ , unless otherwise specified**
**Static characteristics**

|                                  |               |                                                    |     |      |     |            |
|----------------------------------|---------------|----------------------------------------------------|-----|------|-----|------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0V, I_D=1mA$                               | 80  | -    | -   | V          |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}, I_D=15\mu A$                       | 1.2 | 1.6  | 2.0 |            |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=80V, V_{GS}=0V, T_j=25^\circ\text{C}$      | -   | -    | 1   | $\mu A$    |
|                                  |               | $V_{DS}=80V, V_{GS}=0V, T_j=85^\circ\text{C}^{2)}$ | -   | -    | 20  |            |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20V, V_{DS}=0V$                            | -   | -    | 100 | nA         |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=4.5V, I_D=20A$                             | -   | 16.5 | 20  | m $\Omega$ |
|                                  |               | $V_{GS}=10V, I_D=20A$                              | -   | 12.5 | 14  |            |
| Gate resistance <sup>2)</sup>    | $R_G$         | -                                                  | -   | 1.2  | -   | $\Omega$   |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics<sup>2)</sup>**

|                              |              |                                                             |   |     |      |    |
|------------------------------|--------------|-------------------------------------------------------------|---|-----|------|----|
| Input capacitance            | $C_{iss}$    | $V_{GS}=0V, V_{DS}=40V,$<br>$f=1MHz$                        | - | 829 | 1078 | pF |
| Output capacitance           | $C_{oss}$    |                                                             | - | 146 | 190  |    |
| Reverse transfer capacitance | $C_{rss}$    |                                                             | - | 11  | 17   |    |
| Turn-on delay time           | $t_{d(on)}$  | $V_{DD}=40V, V_{GS}=10V,$<br>$I_D=20A, R_{G,ext}=3.5\Omega$ | - | 2   | -    | ns |
| Turn-off delay time          | $t_{d(off)}$ |                                                             | - | 9   | -    |    |
| Rise time                    | $t_r$        |                                                             | - | 1   | -    |    |
| Fall time                    | $t_f$        |                                                             | - | 4   | -    |    |

**Gate Charge Characteristics<sup>2)</sup>**

|                       |               |                                                      |   |      |      |    |
|-----------------------|---------------|------------------------------------------------------|---|------|------|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=40V, I_D=20A,$<br>$V_{GS}=0 \text{ to } 10V$ | - | 2.7  | 3.5  | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                      | - | 3.2  | 4.8  |    |
| Gate charge total     | $Q_g$         |                                                      | - | 14.3 | 18.6 |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                      | - | 3.2  | -    | V  |

**Reverse Diode**

|                                                |               |                                             |   |     |     |    |
|------------------------------------------------|---------------|---------------------------------------------|---|-----|-----|----|
| Diode continuous forward current <sup>2)</sup> | $I_S$         | $T_C=25^\circ C$                            | - | -   | 40  | A  |
| Diode pulse current <sup>2)</sup>              | $I_{S,pulse}$ | $T_C=25^\circ C$                            | - | -   | 160 |    |
| Diode forward voltage                          | $V_{SD}$      | $V_{GS}=0V, I_F=20A,$<br>$T_J=25^\circ C$   | - | 0.9 | 1.2 | V  |
| Reverse recovery time <sup>2)</sup>            | $t_{rr}$      | $V_R=40V, I_F=40A,$<br>$di_F/dt=100A/\mu s$ | - | 31  | -   | ns |
| Reverse recovery charge <sup>2)</sup>          | $Q_{rr}$      |                                             | - | 25  | -   | nC |

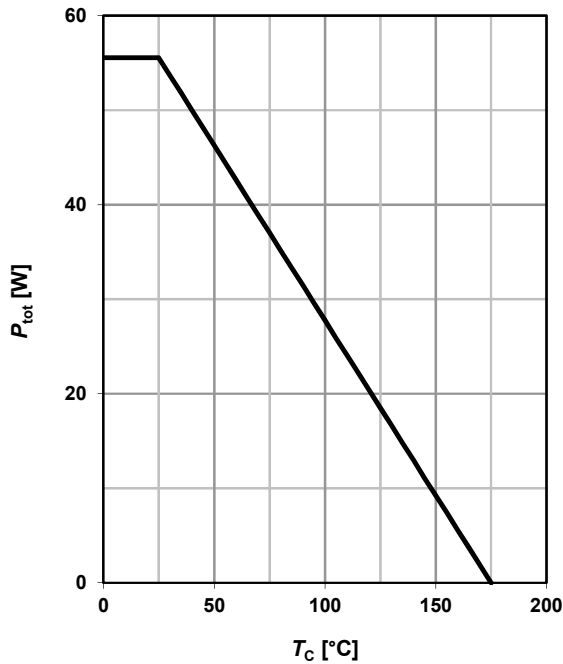
<sup>1)</sup> Practically the current is limited by the overall system design including the customer-specific PCB.

<sup>2)</sup> The parameter is not subject to production test - verified by design/characterization.

<sup>3)</sup> Device on a 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5-7). PCB is vertical in still air.

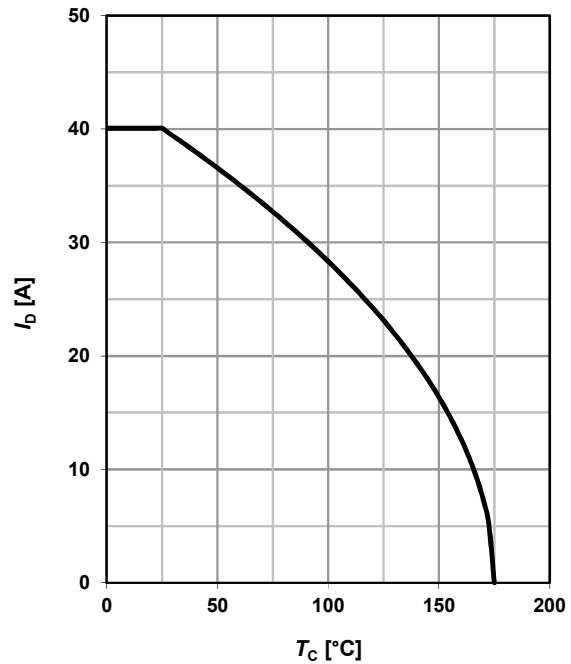
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} = 10 \text{ V}$$



### 2 Drain current

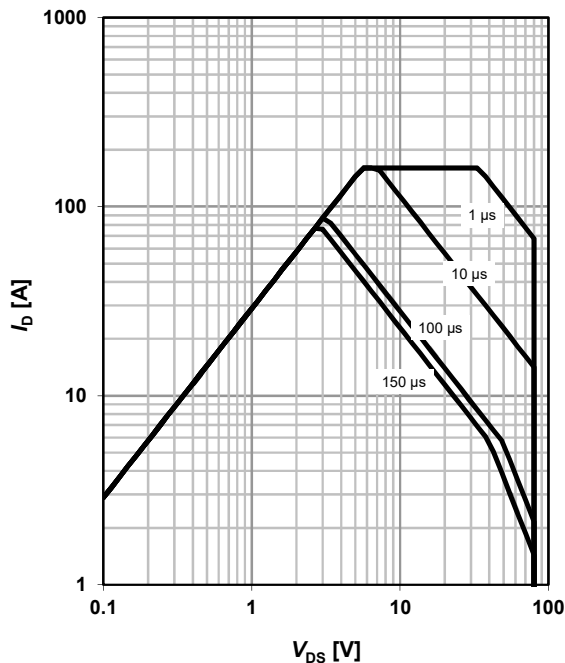
$$I_D = f(T_C); V_{\text{GS}} = 10 \text{ V}$$



### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25^\circ\text{C}; D = 0$$

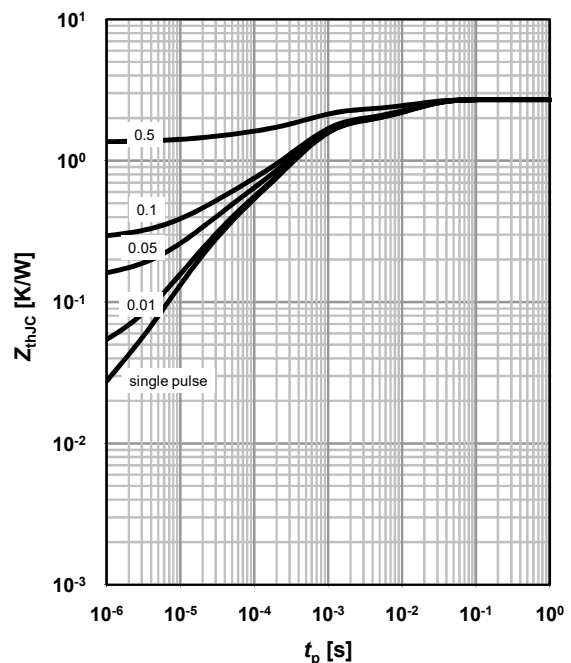
parameter:  $t_p$



### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

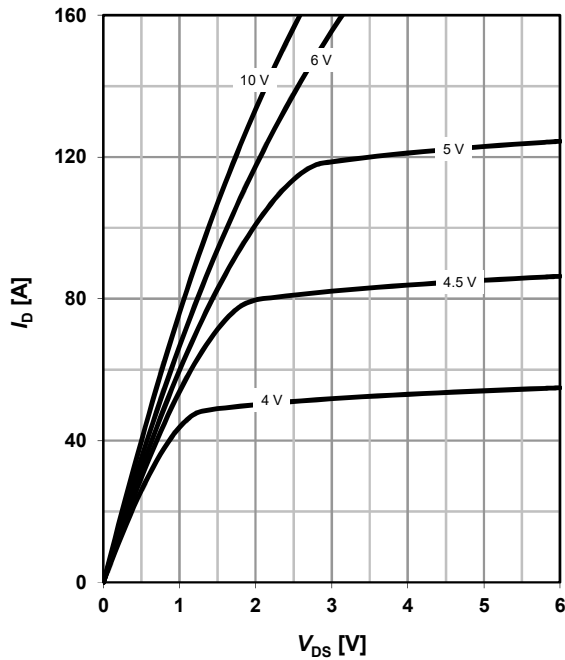
parameter:  $D = t_p/T$



### 5 Typ. output characteristics

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

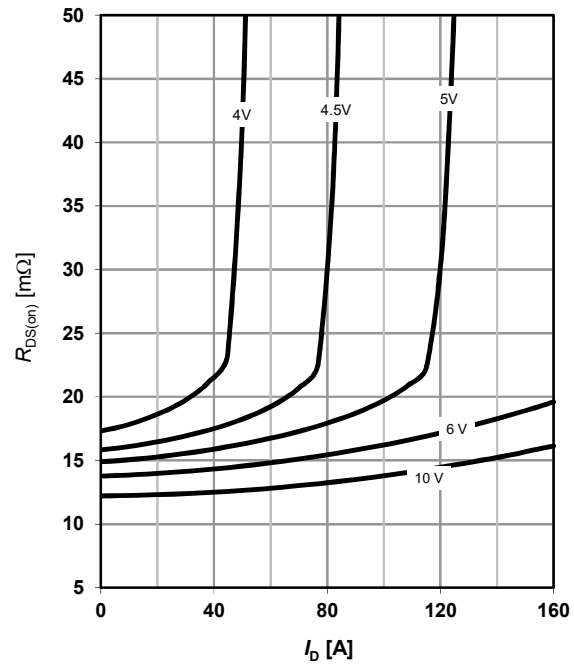
parameter:  $V_{GS}$



### 6 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}$$

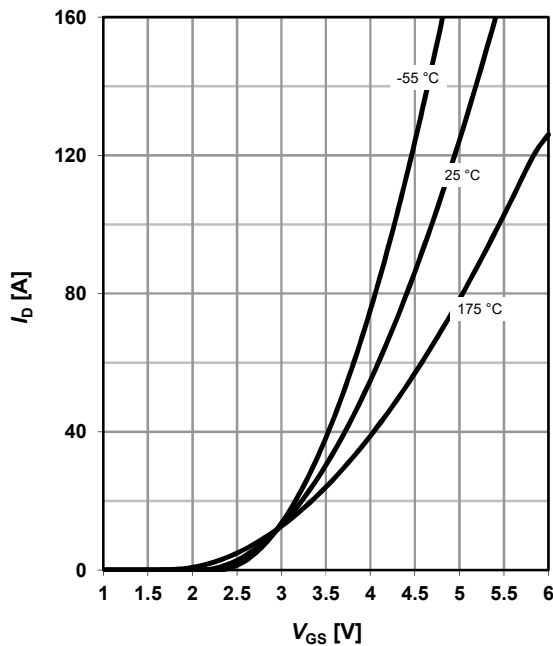
parameter:  $V_{GS}$



### 7 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} = 6\text{V}$$

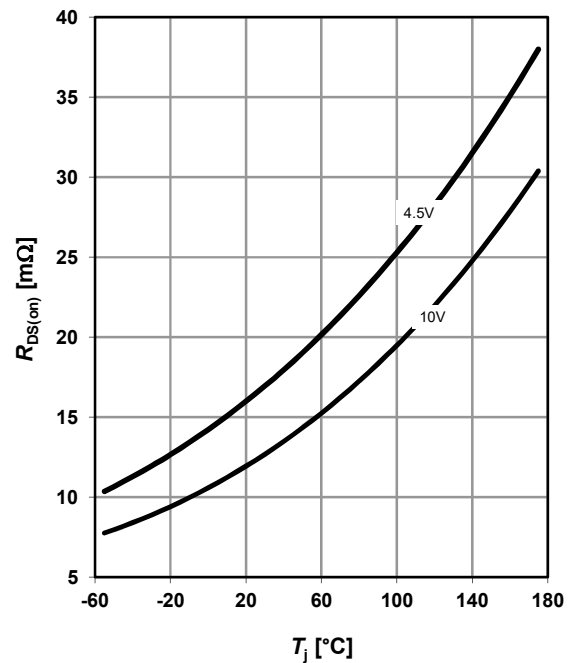
parameter:  $T_j$



### 8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 20\text{A}$$

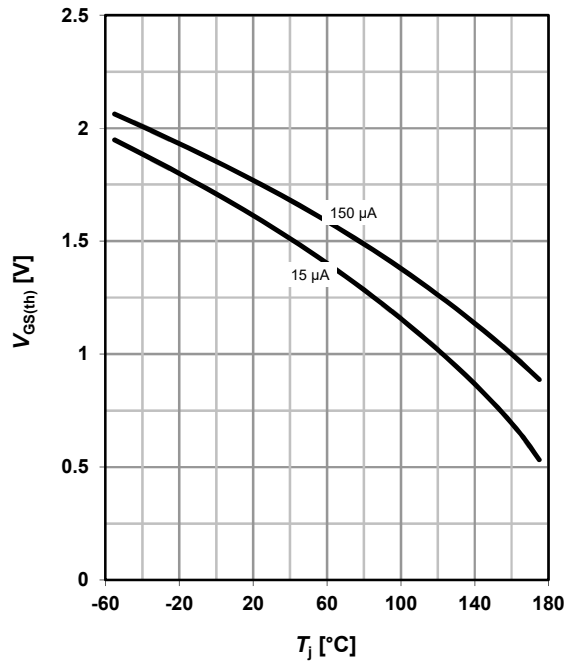
parameter:  $V_{GS}$



### 9 Typ. gate threshold voltage

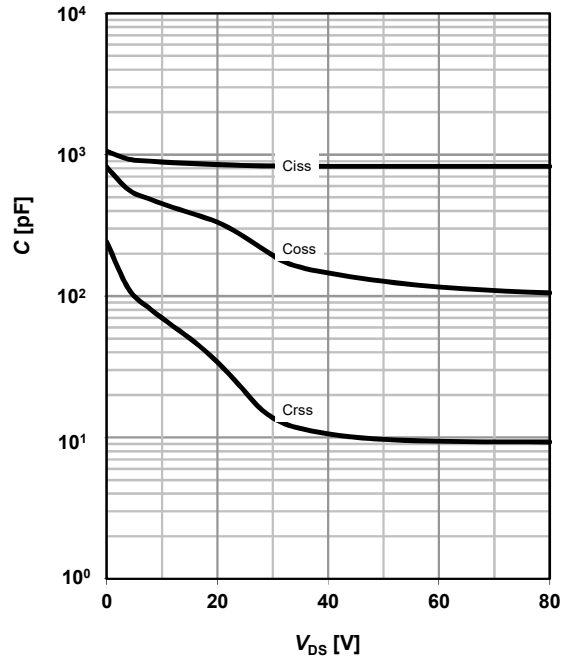
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$$

parameter:  $I_D$



### 10 Typ. capacitances

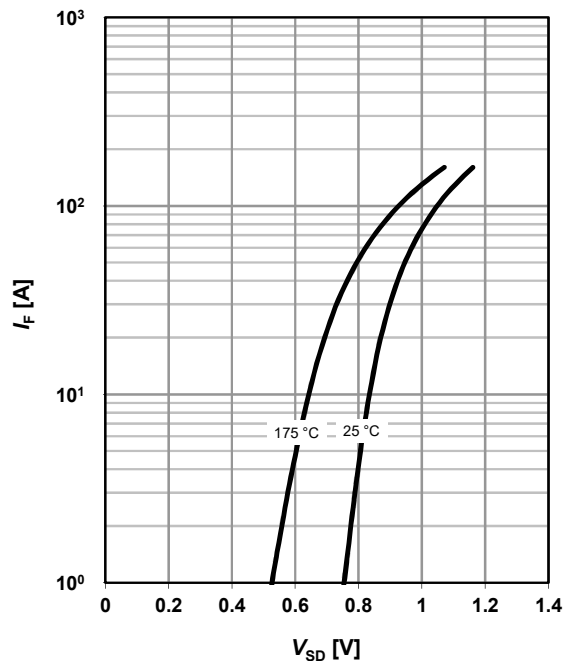
$$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$$



### 11 Typical forward diode characteristics

$$I_F = f(V_{SD})$$

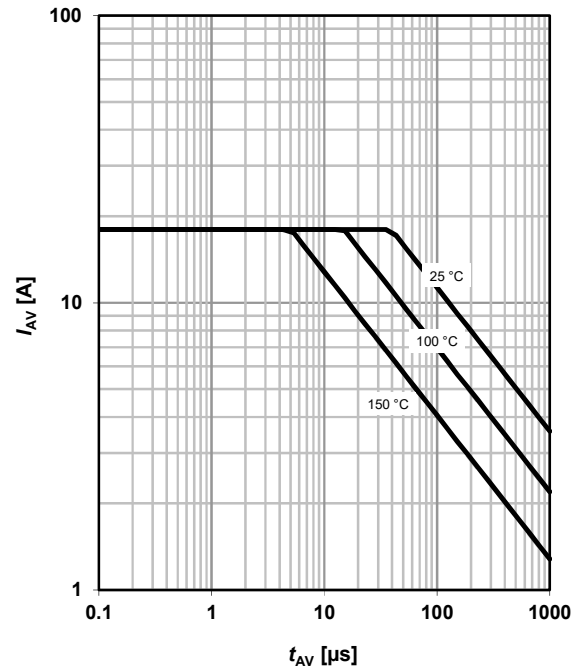
parameter:  $T_j$



### 12 Avalanche characteristics

$$I_{AS} = f(t_{AV})$$

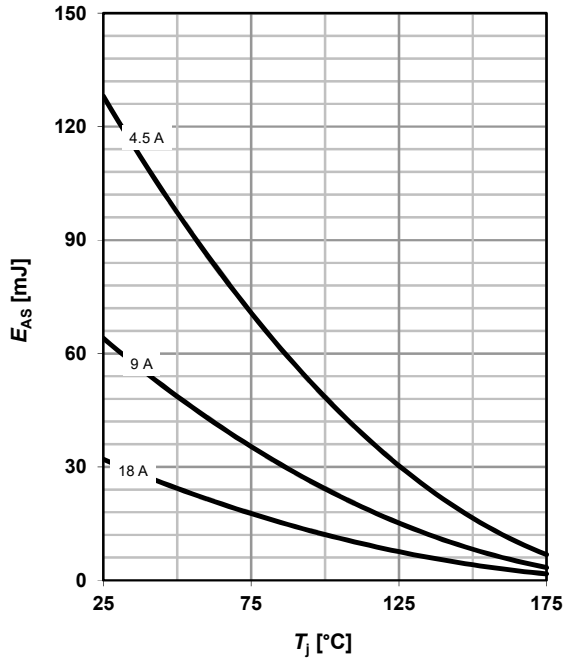
parameter:  $T_{j(start)}$



### 13 Avalanche energy

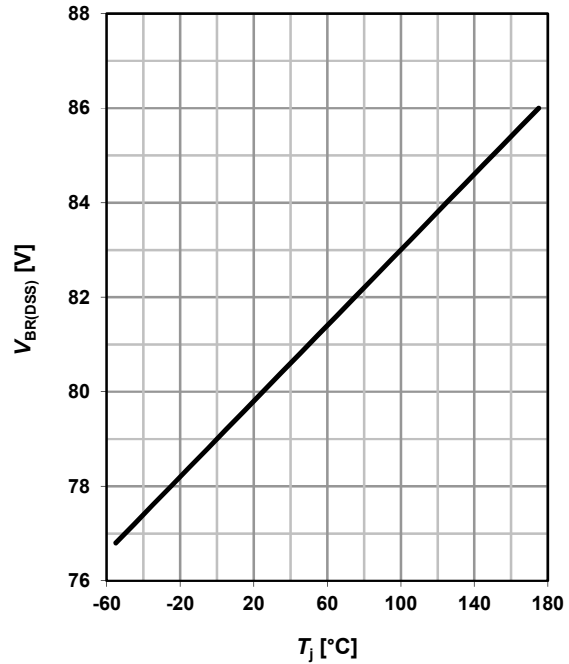
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



### 14 Drain-source breakdown voltage

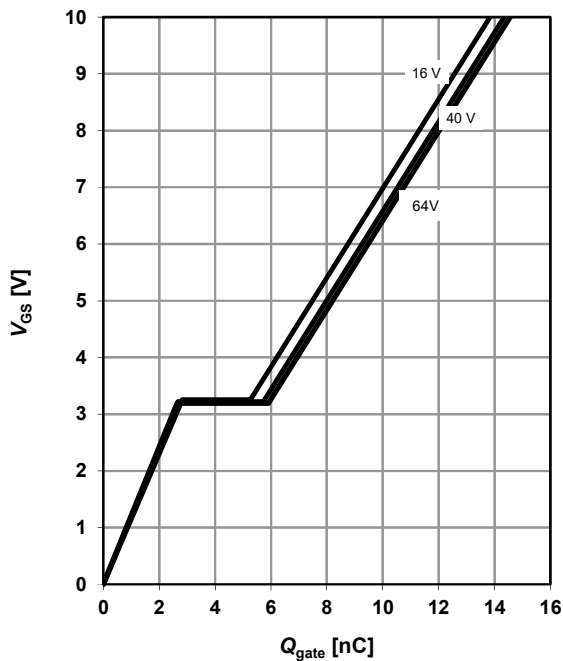
$$V_{BR(DSS)} = f(T_j); I_D = 1\text{ mA}$$



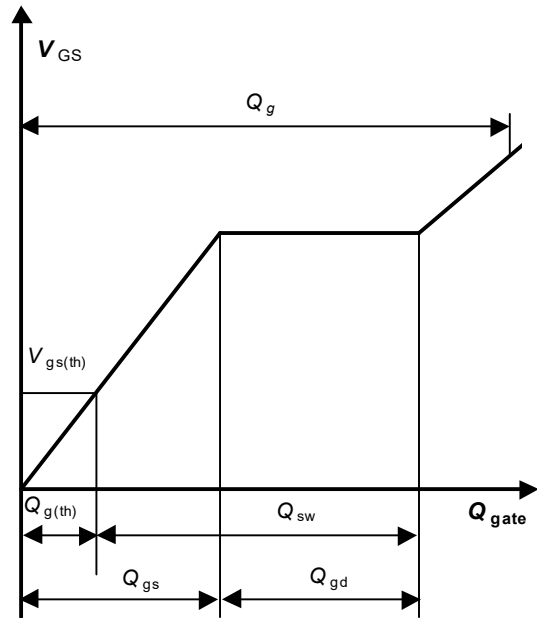
### 15 Typ. gate charge

$$V_{GS} = f(Q_{gate}); I_D = 20\text{ A pulsed}$$

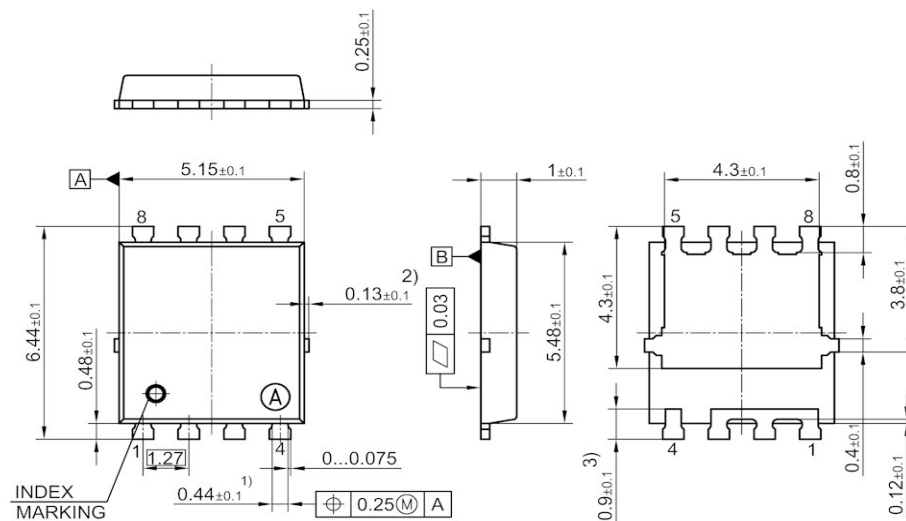
parameter:  $V_{DD}$



### 16 Gate charge waveforms

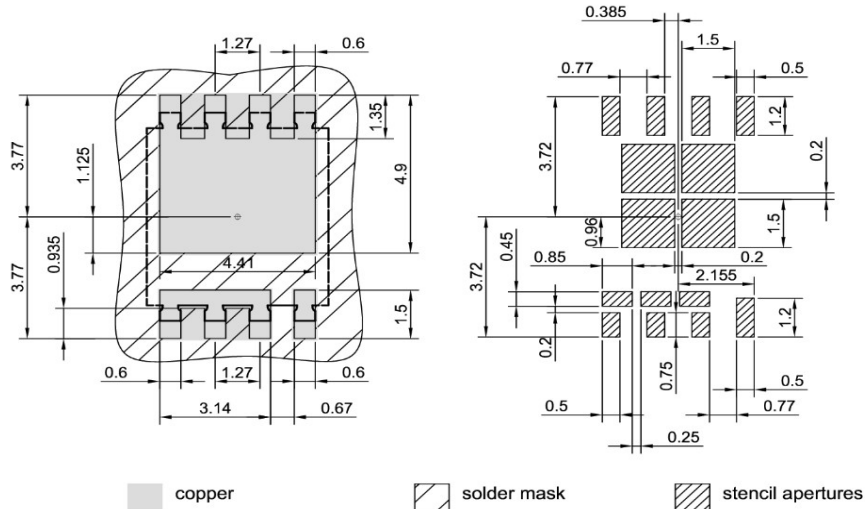


## Package Outline



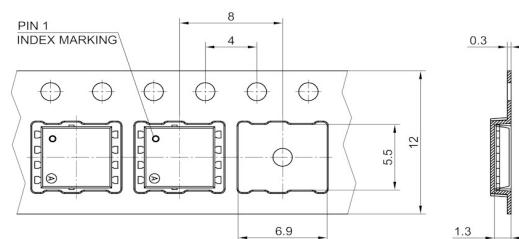
- 1) EXCLUDE MOLD FLASH
  - 2) REMOVAL ON MOLD GATE, INTRUSION 0.1MM AND PROTRUSION 0.1MM
  - 3) LEAD LENGTH UP TO ANTI FLASH LINE
  - 4) ALL METAL SURFACE ARE PLATED, EXCEPT AREA OF CUT
- ALL DIMENSIONS ARE IN UNITS MM  
THE DRAWING IS IN COMPLIANCE WITH ISO 128 & PROJECTION METHOD 1 [ ]

## Footprint



All dimensions are in units mm

## Packaging



**Published by**  
**Infineon Technologies AG**  
**81726 Munich, Germany**

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**Revision History**

| Version      | Date       | Changes          |
|--------------|------------|------------------|
| Revision 1.0 | 2021-01-19 | Final Data Sheet |